

# Agilent HCPL-270L/ 070L/273L/073L Low Input Current High Gain LVTTTL/LVCMOS Compatible 3.3 V Optocouplers Data Sheet

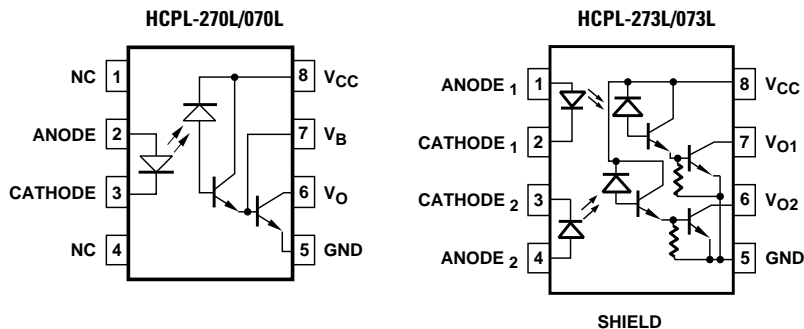
## Description

These high gain series couplers use a Light Emitting Diode and an integrated high gain photodetector to provide extremely high current transfer ratio between input and output. Separate pins for the photodiode and output stage result in LVTTTL compatible saturation voltages and high speed operation. Where desired, the  $V_{CC}$  and  $V_O$  terminals may be tied together to achieve conventional photo-

darlington operation. A base access terminal allows a gain bandwidth adjustment to be made.

These optocouplers are for use in LVTTTL/LVCMOS or other low power applications. A 400% minimum current transfer ratio is guaranteed over 0 to +70°C operating range for only 0.5 mA of LED current.

## Functional Diagram



TRUTH TABLE

LED	$V_O$
ON	LOW
OFF	HIGH

A 0.1  $\mu$ F bypass capacitor connected between pins 8 and 5 is recommended.

**CAUTION:** It is advised that normal static precautions be taken in handling and assembly of this component to prevent damage and/or degradation which may be induced by ESD.

## Features

- Low power consumption
- High current transfer ratio
- Low input current requirements – 0.5 mA
- LVTTTL/LVCMOS compatible output
- Performance guaranteed over temperature 0°C to +70°C
- Base access allows gain bandwidth adjustment
- High output current – 60 mA
- Safety approval, UL, VDE, CSA (pending)

## Applications

- Ground isolate most logic families – LVTTTL/LVCMOS
- Low input current line receiver
- High voltage insulation
- EIA RS-232C line receiver
- Telephone ring detector
- 117 V AC line voltage status indicator – low input power dissipation
- Low power systems – ground isolation

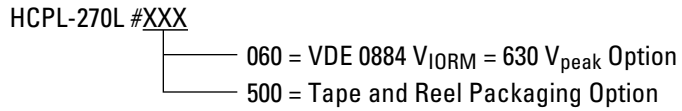
The HCPL-070L and HCPL-073L are surface mount devices packaged in an industry standard SOIC-8 footprint.

The SOIC-8 does not require "through holes" in a PCB. This package occupies approximately one-third the footprint area of the standard dual-in-line package. The lead profile is designed to be compatible with standard surface mount processes.

**Ordering Information**

Specify Part Number followed by Option Number (if desired).

Example:

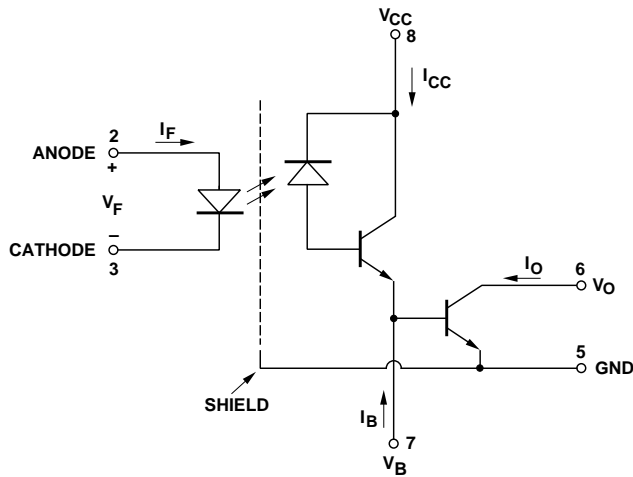


Option data sheets available. Contact your Agilent sales representative or authorized distributor for information.

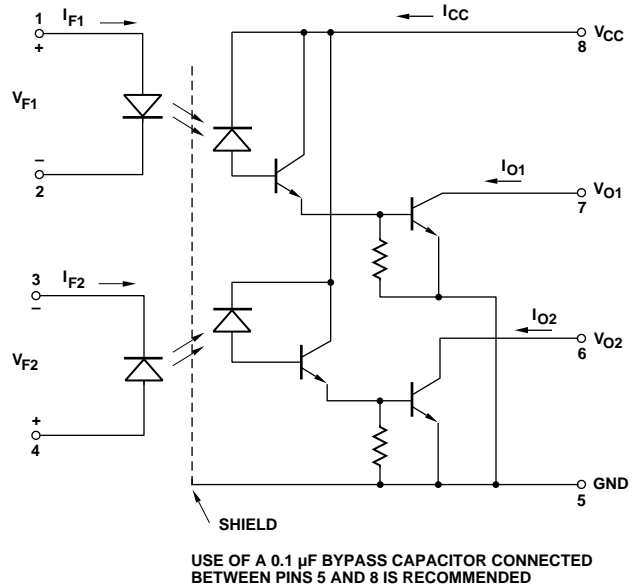
**Selection Guide**

8-Pin DIP (300 Mil)		Small Outline SO-8			
Single Channel Package HCPL-	Dual Channel Package HCPL-	Single Channel Package HCPL-	Dual Channel Package HCPL-	Minimum Input ON Current ( $I_F$ )	Minimum CTR
270L	273L	070L	073L	0.5 mA	400%
				1.6 mA	300%

**Schematic**

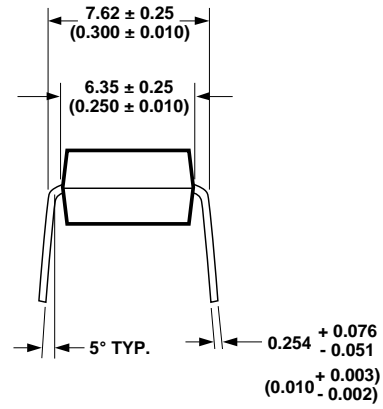
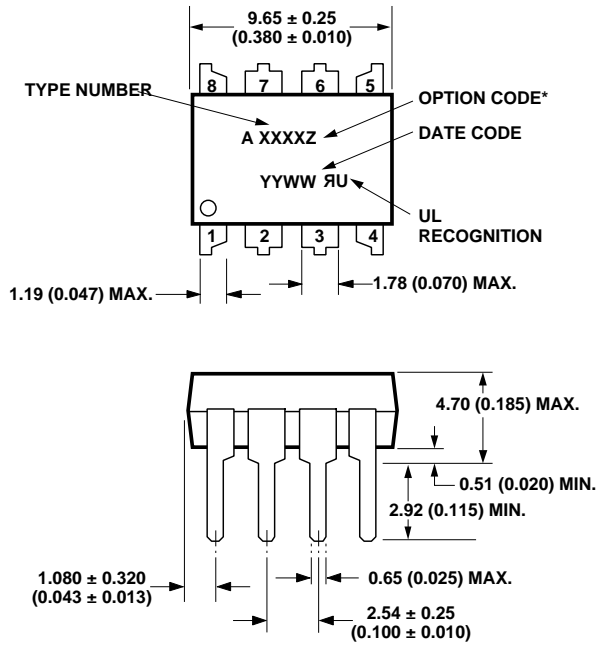


HCPL-270L/HCPL-070L



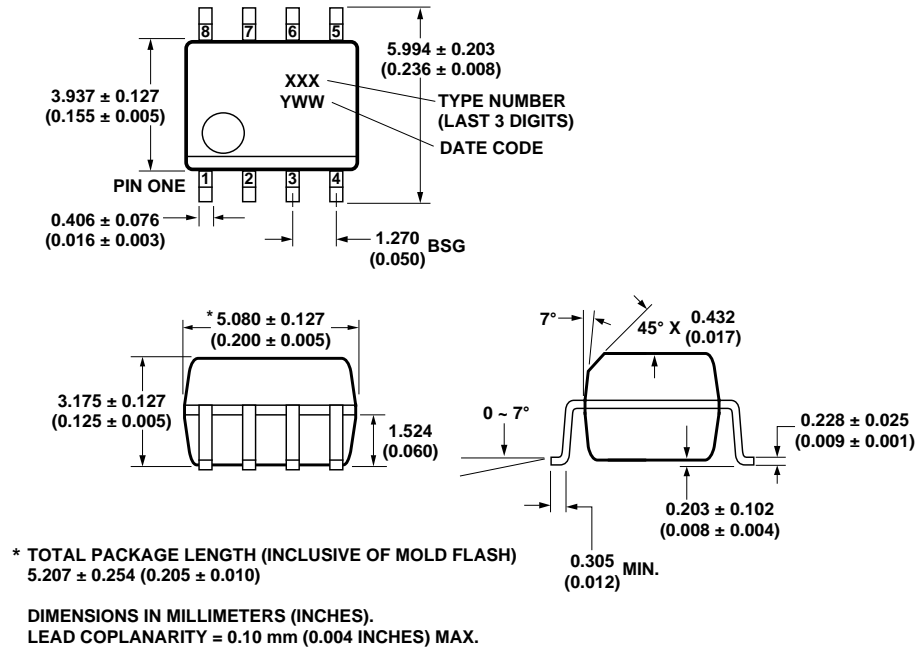
HCPL-273L/HCPL-073L

**Package Outline Drawings**  
**8-Pin DIP Package**

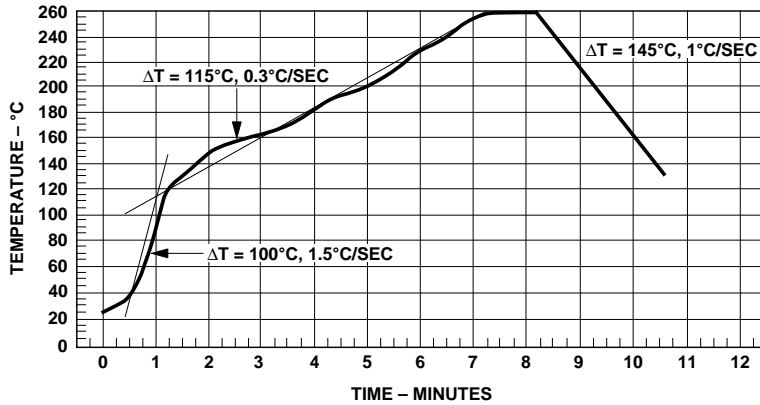


DIMENSIONS IN MILLIMETERS AND (INCHES).  
 \*MARKING CODE LETTER FOR OPTION NUMBERS  
 "L" = OPTION 020  
 OPTION NUMBERS 300 AND 500 NOT MARKED.

**Small Outline SO-8 Package**



**Solder Reflow Temperature Profile (Surface Mount Option Parts)**



(NOTE: USE OF NON-CHLORINE ACTIVATED FLUXES IS HIGHLY RECOMMENDED.)

**Regulatory Information**

The devices contained in this data sheet are pending by the following organizations:

**UL**

Approval (pending) under UL 1577, Component Recognition Program, File E55361.

**CSA**

Approval (pending) under CSA Component Acceptance Notice #5, File CA 88324.

**VDE**

Approval (pending) according to VDE 0884/06.92.

### Insulation and Safety Related Specifications

Parameter	Symbol	8-Pin DIP (300 Mil) Value	SO-8 Value	Units	Conditions
Minimum External Air Gap (External Clearance)	L (101)	7.1	4.9	mm	Measured from input terminals to output terminals, shortest distance through air.
Minimum External Tracking (External Creepage)	L (102)	7.4	4.8	mm	Measured from input terminals to output terminals, shortest distance path along body.
Minimum Internal Plastic Gap (Internal Clearance)		0.08	0.08	mm	Through insulation distance, conductor to conductor, usually the direct distance between the photoemitter and photodetector inside the optocoupler cavity.
Minimum Internal Tracking (Internal Creepage)		NA	NA	mm	Measured from input terminals to output terminals, along internal cavity.
Tracking Resistance (Comparative Tracking Index)	CTI	200	200	Volts	DIN IEC 112/VDE 0303 Part 1.
Isolation Group		IIIa	IIIa		Material Group (DIN VDE 0110, 1/89, Table 1).

### VDE 0884 Insulation Related Characteristics

Description	Symbol	Characteristic	Units
Installation classification per DIN VDE 0110/1.89, Table 1 for rated mains voltage $\leq 300$ V rms for rated mains voltage $\leq 450$ V rms		I-IV	
		I-III	
Climatic Classification		55/100/21	
Pollution Degree (DIN VDE 0110/1.89)		2	
Maximum Working Insulation Voltage	$V_{IORM}$	630	$V_{peak}$
Input to Output Test Voltage, Method b* $V_{PR} = 1.875 \times V_{IORM}$ , 100% Production Test with $t_p = 1$ sec, Partial Discharge $< 5$ pC	$V_{PR}$	1181	$V_{peak}$
Input to Output Test Voltage, Method a* $V_{PR} = 1.5 \times V_{IORM}$ , Type and Sample Test, $t_p = 60$ sec, Partial Discharge $< 5$ pC	$V_{PR}$	945	$V_{peak}$
Highest Allowable Overvoltage* (Transient Overvoltage, $t_{ini} = 10$ sec)	$V_{IOTM}$	6000	$V_{peak}$
Safety Limiting Values (Maximum values allowed in the event of a failure, also see Figure 11, Thermal Derating curve.) Case Temperature Current (Input Current $I_F$ , $P_S = 0$ ) Output Power	$T_S$ $I_{S,INPUT}$ $P_{S,OUTPUT}$	175 400 600	$^{\circ}C$ mA mW
Insulation Resistance at $T_S$ , $V_{IO} = 500$ V	$R_S$	$\geq 10^9$	$\Omega$

\*Refer to the front of the optocoupler section of the current catalog, under Product Safety Regulations section, (VDE 0884), for a detailed description.  
Note: Isolation characteristics are guaranteed only within the safety maximum ratings which must be ensured by protective circuits in application.

**Absolute Maximum Ratings** (No Derating Required up to +85°C)

Parameter	Symbol	Min.	Max.	Units
Storage Temperature	$T_S$	-55	125	°C
Operating Temperature	$T_A$	-40	85	°C
Average Forward Input Current	$I_{F(AVG)}$		20	mA
Peak Forward Input Current (50% Duty Cycle, 1 ms Pulse Width)	$I_{F(PEAK)}$		40	mA
Peak Transient Input Current ( $< 1 \mu s$ Pulse Width, 300 pps)	$I_{F(TRAN)}$		1.0	A
Reverse Input Voltage	$V_R$		5	V
Input Power Dissipation	$P_I$		35	mW
Output Current (Pin 6)	$I_O$		60	mA
Emitter Base Reverse Voltage (Pin 5-7)	$V_{EB}$		0.5	V
Supply Voltage and Output Voltage	$V_{CC}$	-0.5	7	V
Output Power Dissipation	$P_O$		100	mW
Total Power Dissipation	$P_T$		135	mW
Lead Solder Temperature (for Through Hole Devices)	260°C for 10 sec., 1.6 mm below seating plane.			
Reflow Temperature Profile (for SOIC-8 and Option #300)	See Package Outline Drawings section.			

**Recommended Operating Conditions**

Parameter	Symbol	Min.	Max.	Units
Power Supply Voltage	$V_{CC}$	2.7	3.3	V
Forward Input Current (ON)	$I_{F(ON)}$	0.5	12.0	mA
Forward Input Voltage (OFF)	$V_{F(OFF)}$	0	0.8	V
Operating Temperature	$T_A$	0	70	°C

### Electrical Specifications

$0^{\circ}\text{C} \leq T_A \leq +70^{\circ}\text{C}$ ,  $2.7\text{ V} \leq V_{CC} \leq 3.3\text{ V}$ ,  $0.5\text{ mA} \leq I_{F(\text{ON})} \leq 12\text{ mA}$ ,  $0\text{ V} \leq V_{F(\text{OFF})} \leq 0.8\text{ V}$ , unless otherwise specified. All typicals at  $T_A = 25^{\circ}\text{C}$ . (See Note 8.)

Parameter	Sym.	Device HCPL-	Min.	Typ.*	Max.	Units	Test Conditions		Fig.	Note
Current Transfer Ratio	CTR		400	1300	5000	%	$I_F = 0.5\text{ mA}$	$V_{CC} = 3.3\text{ V}$ $V_O = 0.4\text{ V}$	1, 2	2
Logic Low Output Voltage	$V_{OL}$			0.05	0.3	V	$I_F = 1.6\text{ mA}$ , $I_O = 8\text{ mA}$	$V_{CC} = 3.3\text{ V}$		
				0.05	0.4	V	$I_F = 5.0\text{ mA}$ , $I_O = 15\text{ mA}$			
Logic High Output Current	$I_{OH}$			5	25	$\mu\text{A}$	$V_O = V_{CC} = 3.3\text{ V}$	$I_F = 0\text{ mA}$		2
Logic Low Supply Current	$I_{CCL}$	270L/070L		0.0015	0.15	mA	$V_{CC} = 3.3\text{ V}$	$I_{F1} = I_{F2} = 1.6\text{ mA}$ $V_{O1} = V_{O2} = \text{Open}$		
		273L/073L		0.0015	0.3	mA				
Logic High Supply Current	$I_{CCH}$	270L/070L		0.002	1	$\mu\text{A}$	$V_{CC} = 3.3\text{ V}$	$I_{F1} = I_{F2} = 0\text{ mA}$ $V_{O1} = V_{O2} = \text{Open}$		
		273L/073L		0.002	2	$\mu\text{A}$				
Input Forward Voltage	$V_F$			1.5	1.7	V	$T_A = 25^{\circ}\text{C}$	$I_F = 1.6\text{ mA}$		3, 4
Input Reverse Breakdown Voltage	$BV_R$		5.0			V	$I_R = 10\text{ }\mu\text{A}$ , $T_A = 25^{\circ}\text{C}$			2
Input Capacitance	$C_{IN}$			60		pF	$f = 1\text{ MHz}$ , $V_F = 0$			2

\*All typical values at  $T_A = 25^{\circ}\text{C}$  and  $V_{CC} = 3.3\text{ V}$ , unless otherwise noted.

**Switching Specifications (AC)**Over Recommended Operating Conditions ( $T_A = 0^\circ\text{C}$  to  $+70^\circ\text{C}$ ),  $V_{CC} = 3.3\text{ V}$ , unless otherwise specified. (See Note 8.)

Parameter	Sym.	Device HCPL-	Min.	Typ.*	Max.	Units	Test Conditions	Fig.	Note
Propagation Delay Time to Logic Low at Output	$t_{PHL}$				30	$\mu\text{s}$	$T_A = 25^\circ\text{C}$ $I_F = 0.5\text{ mA}$ $R_I = 4.7\text{ k}\Omega$	5	2
Propagation Delay Time to Logic High at Output	$t_{PLH}$				90	$\mu\text{s}$	$T_A = 25^\circ\text{C}$ $I_F = 0.5\text{ mA}$ , $R_L = 4.7\text{ k}\Omega$	5	2
Common Mode Transient Immunity at Logic High Level Output	$ICM_H$		1000	10000		$\text{V}/\mu\text{s}$	$I_F = 0\text{ mA}$ , $T_A = 25^\circ\text{C}$ , $R_I = 2.2\text{ k}\Omega$ $ V_{CM}  = 10\text{ V}_{p-p}$	6	2, 6, 7
Common Mode Transient Immunity at Logic Low Level Output	$ICM_L$		1000	10000		$\text{V}/\mu\text{s}$	$I_F = 1.6\text{ mA}$ , $T_A = 25^\circ\text{C}$ , $R_I = 2.2\text{ k}\Omega$ $ V_{CM}  = 10\text{ V}_{p-p}$	6	2, 6, 7

\*All typical values at  $T_A = 25^\circ\text{C}$  and  $V_{CC} = 3.3\text{ V}$ , unless otherwise noted.



## Package Characteristics

Parameter	Sym.	Device HCPL-	Min.	Typ.*	Max.	Units	Test Conditions	Fig.	Note
Input-Output Momentary Withstand Voltage**	V <sub>ISO</sub>		2500			V rms	RH ≤ 50%, t = 1 min., T <sub>A</sub> = 25°C		4, 9
Resistance (Input-Output)	R <sub>I-O</sub>			10 <sup>12</sup>		Ω	V <sub>I-O</sub> = 500 Vdc RH ≤ 45%		4
Capacitance (Input-Output)	C <sub>I-O</sub>			0.6		pF	f = 1 MHz		11
Input-Input Insulation Leakage Current	I <sub>I-I</sub>		0.005			μA	RH ≤ 45% V <sub>I-I</sub> = 500 Vdc		5
Input-Input Insulation Leakage Current	R <sub>I-I</sub>			10 <sup>11</sup>		Ω			5
Capacitance (Input-Input)	C <sub>I-I</sub>	2730		0.03		pF			5
		2731							
		0730		0.25					
		0731							

\*All typical values at T<sub>A</sub> = 25°C, unless otherwise noted.

\*\*The Input-Output Momentary Withstand Voltage is a dielectric voltage rating that should not be interpreted as an input-output continuous voltage rating. For the continuous voltage rating refer to the VDE 0884 Insulation Characteristics Table (if applicable), your equipment level safety specification or Agilent Application Note 1074 entitled "Optocoupler Input-Output Endurance Voltage."

### Notes:

- Pin 5 should be the most negative voltage at the detector side.
- Each channel.
- DC CURRENT TRANSFER RATIO (CTR) is defined as the ratio of output collector current, I<sub>O</sub>, to the forward LED input current, I<sub>F</sub>, times 100%.
- Device considered a two-terminal device: pins 1, 2, 3, and 4 shorted together, and pins 5, 6, 7, and 8 shorted together.
- Measured between pins 1 and 2 shorted together, and pins 3 and 4 shorted together.
- Common mode transient immunity in a Logic High level is the maximum tolerable (positive) dV<sub>CM</sub>/dt of the common mode pulse, V<sub>CM</sub>, to assure that the output will remain in a Logic High state (i.e., V<sub>O</sub> > 2.0 V). Common mode transient immunity in a Logic Low level is the maximum tolerable (negative) dV<sub>CM</sub>/dt of the common mode pulse, V<sub>CM</sub>, to assure that the output will remain in a Logic Low state (i.e., V<sub>O</sub> < 0.8 V).
- In applications where dV/dt may exceed 50,000 V/μs (such as static discharge) a series resistor, R<sub>CC</sub>, should be included to protect the detector IC from destructively high surge currents. The recommended value is R<sub>CC</sub> = 110 Ω.
- Use of a 0.1 μF bypass capacitor connected between pins 5 and 8 adjacent to the device is recommended.
- In accordance with UL 1577, each optocoupler is proof tested by applying an insulation test voltage > 3000 V rms for 1 second (leakage detection current limit, I<sub>I-O</sub> < 5 μA).
- In accordance with UL 1577, each optocoupler is proof tested by applying an insulation test voltage > 6000 V rms for 1 second (leakage detection current limit, I<sub>I-O</sub> < 5 μA).
- Measured between the LED anode and cathode shorted together and pins 5 through 8 shorted together.
- Derate linearly above 65°C free-air temperature at a rate of 2.3 mW/°C for the SO-8 package.

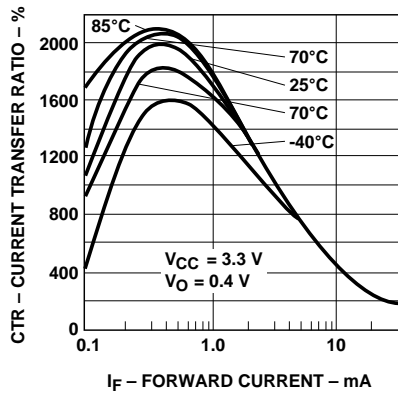


Figure 1. Current transfer ratio vs. forward current.

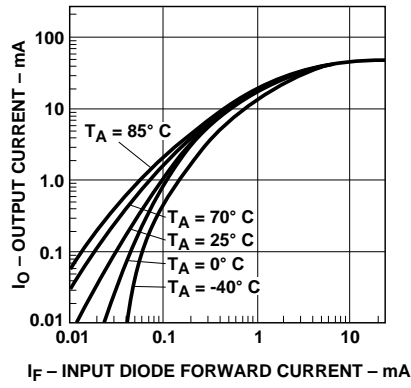


Figure 2. Output current vs. input diode forward current.

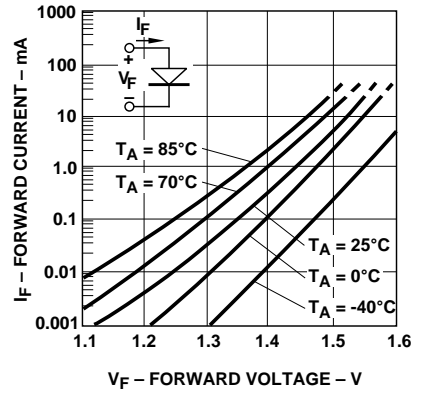


Figure 3. Input diode forward current vs. forward voltage.

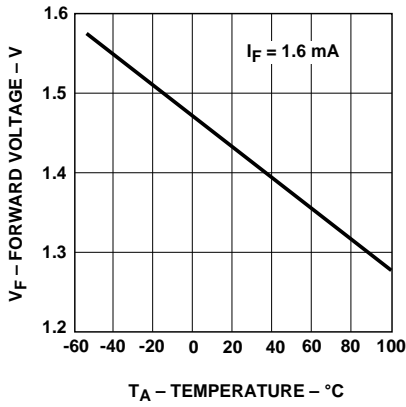


Figure 4. Forward voltage vs. temperature.

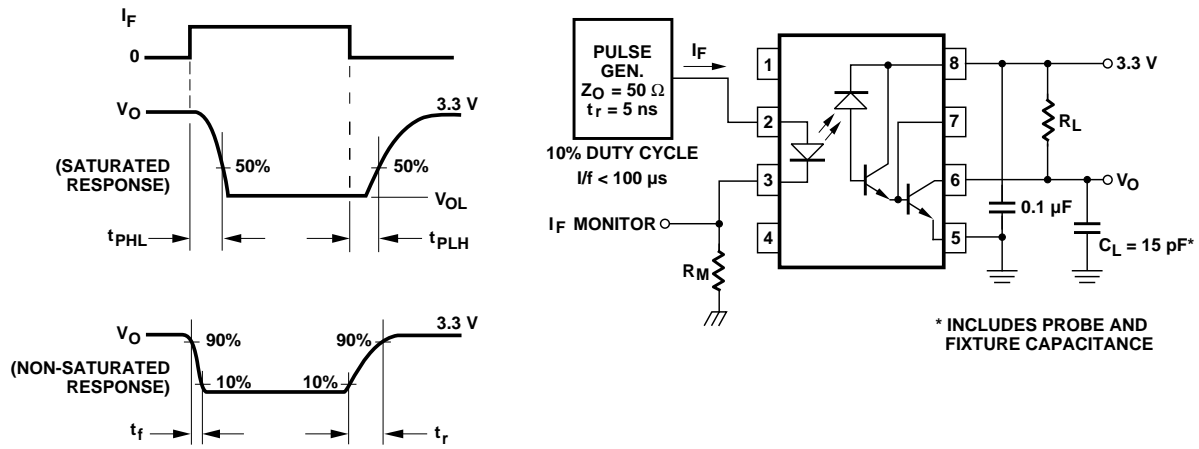


Figure 5. Switching test circuit.

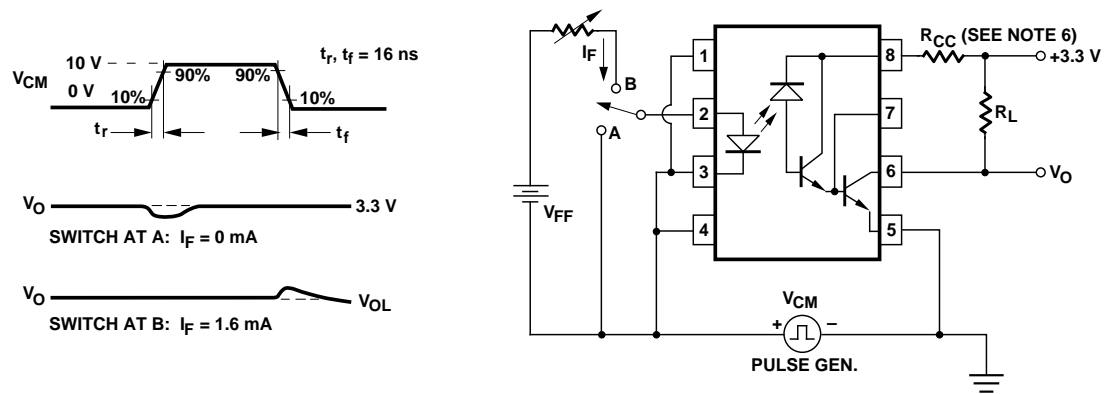


Figure 6. Test circuit for transient immunity and typical waveforms.

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